

Zoznam informačných bulletinov		
Č.	Názov	Typ techniky
1.	Rapid Analysis of Wear Metals in Used Oils by Automated ICP-OES - Highest Sample Throughput at Lowest Cost	ICP
2.	The Elemental Analysis of Geological Materials - Elegant solutions from SPECTRO Analytical Instruments	XRF
3.	SPECTRO Performance Quality System (SPQS) - A Concept for Improving Result Quality in Optical Emission Spectroscopy	SPARK
4.	Simultaneous ICP-MS in the Pharmaceutical Industry - Powerful New Tool for Elemental Analysis	ICP-MS
5.	Elemental Analysis in Forensic Science - Powerful Tools for Investigation and Evidence	XRF, microXRF
6.	Chlorine Production - Eliminating Mercury - The role of trace element analysis in the membrane process	ICP
7.	Cost-Effective Condition Monitoring - The SPECTRO GENESIS Petrochem ICP-OES	ICP
8.	Innovations in Optics for Emission Spectroscopy - Performance Meets Flexibility	SPARK
9.	Metallic Elements in Pharmaceuticals - Analysis for Compliance and Quality Control	ICP
10.	Improved Determination of Carbon in Cast Iron - A new approach to cast iron analysis by optical emission spectrometry	SPARK
11.	Aluminum Recycling: Adding Value by Analysis	SPARK, XRF
12.	Fully Simultaneous ICP-MS - The new approach to isotope geochemistry	ICP-MS
13.	TURBOQUANT - SPECTRO's Answer to Screening Analysis	XRF
14.	"All that glitters is not gold" - Precious Metals Analysis	XRF, SPARK, ICP
15.	Analyzing Precious Metals	XRF
16.	SVHC Elemental Screening with XRF - Helping to meet the legislative challenge	XRF
17.	Condition Monitoring - The Role of Elemental Analysis - Oil analysis saves money and prevents equipment failure	ICP, XRF
18.	Elemental Analysis in Waste Oil Recovery and Recycling - Saving energy and protecting the environment	XRF, ICP
19.	Lead Batteries - a Problem or a Solution? - Elemental analysis in lead processing and recycling	SPARK

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20.	Simplicity and Sophistication in Metals Analysis - Advances in Optical Emission Spectrometry	SPARK
21.	Environmental Screening by X-Ray Environmental Screening by X-Ray - Analytical tools for a cleaner world	XRF, ICP
22.	Scrap Metal Sorting with the SPECTRO xSORT Handheld XRF Spectrometer - The key to pro table metals recycling	XRF
23.	Elemental Compliance Screening with XRF - Helping to meet the legislative challenge	XRF, ICP
24.	Improved Spectrometric Analysis for Positive Material Identification (PMI)	XRF, SPARK
25.	Positive Material Identification (PMI) by Spectrochemical Analysis - The essential tool for infrastructure integrity testing in the process industries	XRF, SPARK
26.	Detection and Analysis of Inclusions Using SPECTROLAB's (LAVM11) Single Spark Evaluation Technology - Background and Physics of the Technology	SPARK
27.	Isotope Ratio Measurements with a Fully Simultaneous Mattauch-Herzog ICP-MS A Powerful Tool for Isotope and Elemental Analysis	ICP-MS
28.	Selecting your ICP-OES analyzer's plasma interface: axial-view, radial-view, dual-view, or new MultiView	ICP
29.	How new spectrometer technologies substantially cut operating costs	ICP
30.	Which Spectrometer Optical Technology Offers Superior Performance? Echelle vs. ORCA	ICP
31.	Elemental Impurities in Pharmaceutical Products – Analysis using an Energy- Dispersive X-ray Fluorescence Spectrometer	XRF
32.	Why Flame AAS Users Are Moving Up to ICP-OES	ICP
33.	Mitigating Matrix Effects with Advanced Spectra-Handling Functionality When Using XRF for High-Accuracy Elemental Analysis	XRF
34.	Elemental Analysis of Airborne Particles Evaluating XRF, ICP-OES, and ICP-MS Analytical Technologies	XRF, ICP
35.	Nine Elements That Challenge Handheld XRF Analyzers — But Are Easy for OES	SPARK
36.	Four reasons to upgrade to next-generation ICP-OES technology	ICP

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37.	X-ray fluorescence analysis of polymers	XRF
38.	Five reasons for upgrading to next-generation ED-XRF analyzer	XRF
39.	High-Performamnce Agronomy Analysis Using ICP-OES	ICP
40.	High-Precision Analysis of Small Parts for Aerospace and Automotive Applications	SPARK, XRF
41.	Mobile metal analyzers: on-the-spot solutions for incoming and outgoing inspection	SPARK, XRF
42.	Selecting your ICP-OES analyzer's plasma interface: axial-view, radial-view, dual-view, or new MultiView	ICP
43.	PMT vs. CMOS: The paradigm shift in metal analyzer detector technologies	SPARK
44.	Seeing the Plasma in a Whole new Light: Advantages of DSOI Technology	ICP
45.	A New Approach to ICP-OES Analysis for Environmental Testing	ICP
46.	The XRF Principle: The Fundamentals of Energy Dispersive X-ray Fluorescence Technology	XRF
47.	Future-Proof Solutions for Elemental Compliance	XRF, ICP
48.	Analyzing Precious Metals	XRF, SPARK, ICP
49.	Future-Proof Research: New Performance and Scope for Elemental Analysis in Academia	ICP, XRF
50.	Standard-based Material Testing: Standard-based Material Testing: Do Your Analyses Fulfill Current Requirements?	SPARK
51.	Verification of the Authenticity and Classification of Gemstones Using XRF	XRF
52.	Ten Reasons You Need a Next-Generation ICP-OES for Routine Analyses	ICP
53.	Surprising New Capabilities of ED-XRF Technology	XRF
54.	Simple, Easy, Powerful Identification Software for XRF Spectrometers	XRF
55.	Effluent Phosphate Recovery & Recycling: The Latest Analytical Solutions	XRF, ICP
56.	Fine Chemicals: A Flexible Analytical Solution	ICP
57.	Five More Reasons to Upgrade to Next-Generation ICP-OES Technology	ICP
58.	Analytical Challenges and Solutions for Mining and Geochemistry	ICP, XRF